

Supporting information

Electric field assisted growth and field emission properties of thermally oxidized CuO nanowires

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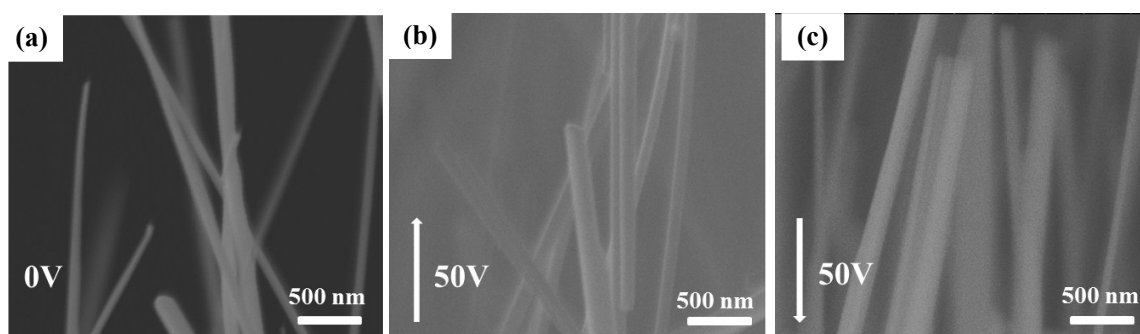


Fig. S1 Cross-sectional SEM images of the tips of (a) 0V, (b) 50V upward, and (c) 50V downward.



Fig. S2 Cross-sectional SEM images of the upper part of 50V upward after field emission test.